

Notice of References Cited	Application/Control No. 10/696,756	Applicant(s)/Patent Under Reexamination BOYD ET AL	
	Examiner CongVan Tran	Art Unit 2683	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,791,976 B2	09-2004	Huh et al.	370/356
	B	US-6,353,736 B1	03-2002	Hiromichi, Ishida	455/406
	C	US-6,735,457 B1	05-2004	Link et al.	455/575.1
	D	US-6,052,581 A	04-2000	O'Connell et al.	455/419
	E	US-5,457,732 A	10-1995	Goldberg, Steven J.	340/7.23
	F	US-6,104,783 A	08-2000	DeFino, John M.	379/38
	G	US-6,366,785 B2	04-2002	Saarela et al.	455/466
	H	US-4,677,656	06-1987	Burke et al.	455/403
	I	US-2003/0022684	01-2003	Seeger, Stephen C.	455/521
	J	US-2003/0050039	03-2003	Baba et al.	455/404
	K	US-5,956,632 A	09-1999	Shon, Jung-Hak	455/404.1
	L	US-6,198,947 B1	03-2001	Barber, Clifton J.	455/563
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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